

DIM800FSM17-A000

Single Switch IGBT Module

Preliminary Information

DS5461-1.0 May 2001

Replaces May 2001, version DS5461-1.0

FEATURES

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Non Punch Through Silicon
- Isolated MMC Base with AIN Substrates

APPLICATIONS

- Inverters
- Motor Controllers
- Traction Drives

The Powerline range of modules includes half bridge, chopper, dual and single switch configurations covering voltages from 600V to 3300V and currents up to 2400A.

The DIM800FSM17-A000 is a single switch 1700V, n channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus full $10\mu s$ short circuit withstand. This module is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM800FSM17-A000

Note: When ordering, please use the whole part number.

KEY PARAMETERS

V _{CES}		1700V
V _{CE(sat)} *	(typ)	2.7V
I _C	(max)	800A
I _{C(PK)}	(max)	1600A

^{*(}measured at the power busbars and not the auxiliary terminals)

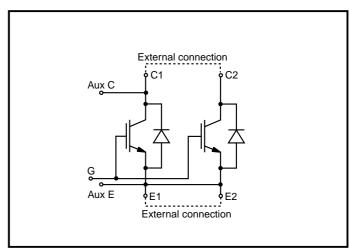


Fig. 1 Single switch circuit diagram

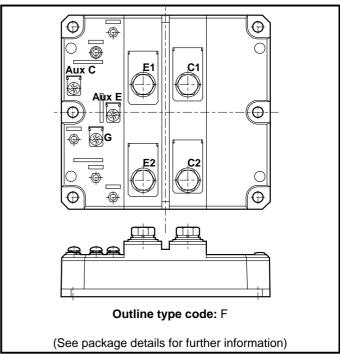


Fig. 2 Electrical connections - (not to scale)



ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	$V_{GE} = 0V$	1700	V
V _{GES}	Gate-emitter voltage	-	±20	V
I _c	Continuous collector current	$T_{case} = 75^{\circ}C$	800	А
I _{C(PK)}	Peak collector current	1ms, T _{case} = 105°C	1600	Α
P _{max}	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	6940	W
l²t	Diode I ² t value	$V_R = 0, t_p = 10 \text{ms}, T_{vj} = 125^{\circ}\text{C}$	120	kA ² s
V _{isol}	Isolation voltage - per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	4000	V
Q_{PD}	Partial discharge - per module	IEC1287. V ₁ = 1500V, V ₂ = 1100V, 50Hz RMS	10	рС



THERMAL AND MECHANICAL RATINGS

Internal insulation material: AIN
Baseplate material: AISiC
Creepage distance: 20mm
Clearance: 10mm
CTI (Critical Tracking Index): 175

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
R _{th(j-c)}	Thermal resistance - transistor (per arm)	Continuous dissipation -	-	-	18	°C/kW
		junction to case				
R _{th(j-c)}	Thermal resistance - diode (per arm)	Continuous dissipation -	-	-	40	°C/kW
		junction to case				
R _{th(c-h)}	Thermal resistance - case to heatsink	Mounting torque 5Nm	-	-	8	°C/kW
	(per module)	(with mounting grease)				
T _j	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
-	Screw torque	Mounting - M6	-	-	5	Nm
		Electrical connections - M4	-	-	2	Nm
		Electrical connections - M8	-	-	10	Nm



ELECTRICAL CHARACTERISTICS

 $T_{case} = 25$ °C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	. Тур.	Max.	Units
I _{CES}	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}$	-	-	1	mA
		$V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 125^{\circ}C$	-	-	25	mA
I _{GES}	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$	-	-	4	μА
$V_{\text{GE(TH)}}$	Gate threshold voltage	$I_{\rm C} = 40 {\rm mA}, V_{\rm GE} = V_{\rm CE}$	4.5	5.5	6.5	V
V _{CE(sat)} †	Collector-emitter saturation voltage	V _{GE} = 15V, I _C = 800A	-	2.7	3.2	V
		$V_{GE} = 15V, I_{C} = 800A, T_{case} = 125$	°C -	3.4	4.0	V
I _F	Diode forward current	DC	-	-	800	А
I _{FM}	Diode maximum forward current	t _p = 1ms	-	-	1600	А
V _F [†]	Diode forward voltage	I _F = 800A	-	2.2	2.5	V
		I _F = 800A, T _{case} = 125°C	-	2.3	2.6	V
C _{ies}	Input capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz	-	60	-	nF
L _M	Module inductance	-	-	20	-	nH
R _{INT}	Internal transistor resistance	-	-	0.27	-	mΩ
SC _{Data}	Short circuit. I _{SC}	$T_j = 125^{\circ}C, V_{CC} = 1000V,$	1 -	3700	-	А
		$t_p \le 10 \mu s$, $V_{CE(max)} = V_{CES} - L^*$. di/dt	2 -	3200	-	А
		IEC 60747-9				

Note:

[†] Measured at the power busbars and not the auxiliary terminals)

 $^{^{\}ast}$ L is the circuit inductance + $\rm L_{M}$



ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise

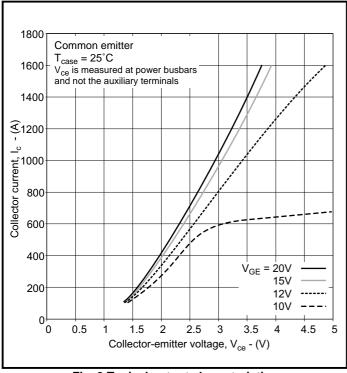
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t _{d(off)}	Turn-off delay time	I _C = 800A	-	1250	-	ns
t _f	Fall time	$V_{GE} = \pm 15V$	-	170	-	ns
E _{OFF}	Turn-off energy loss	V _{CE} = 900V	-	230	-	mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 2.2\Omega$	-	250	-	ns
t _r	Rise time	L ~ 100nH	-	250	-	ns
E _{on}	Turn-on energy loss		-	220	-	mJ
Q_g	Gate charge		-	9.0	-	μС
Q _{rr}	Diode reverse recovery charge	I _F = 800A, V _R = 900V,	-	200	-	μС
I _{rr}	Diode reverse current	dl _F /dt = 4000A/μs	-	460	-	А
E _{REC}	Diode reverse recovery energy		-	130	-	mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t _{d(off)}	Turn-off delay time	I _C = 800A	-	1500	-	ns
t _f	Fall time	$V_{GE} = \pm 15V$	-	200	-	ns
E _{OFF}	Turn-off energy loss	V _{CE} = 900V	-	360	-	mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 2.2\Omega$	-	400	-	ns
t,	Rise time	L ~ 100nH	-	250	-	ns
E _{on}	Turn-on energy loss		-	340	-	mJ
Q _{rr}	Diode reverse recovery charge	$I_F = 800A, V_R = 900V,$	-	330	-	μС
l _{rr}	Diode reverse current	dI _F /dt = 4000A/μs	-	530	-	Α
E _{REC}	Diode reverse recovery energy		-	200	-	mJ



TYPICAL CHARACTERISTICS



1800 Common emitter $T_{case} = 125^{\circ}C$ 1600 V_{ce} is measured at power busbars and not the auxiliary terminals 1400 € ₁₂₀₀ Collector current, I_c 400 $V_{GE} = 20V$ 15V 200 12V 10V 0 2.5 2 3 3.5 5 5.5 0.5 4.5 0 Collector-emitter voltage, V_{ce} - (V)

Fig. 3 Typical output characteristics



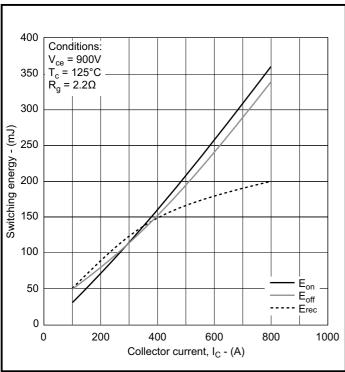


Fig. 5 Typical switching energy vs collector current

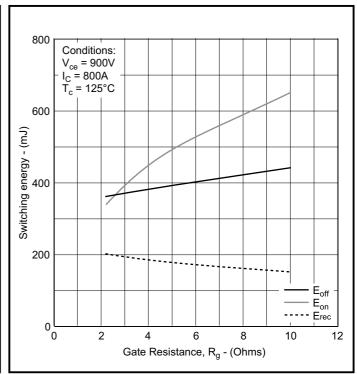
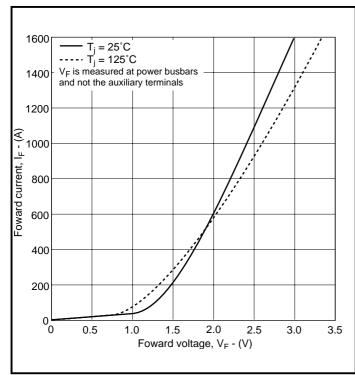


Fig. 6 Typical switching energy vs gate resistance





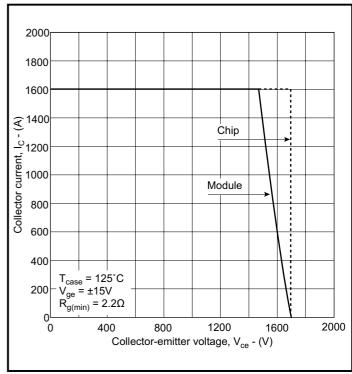
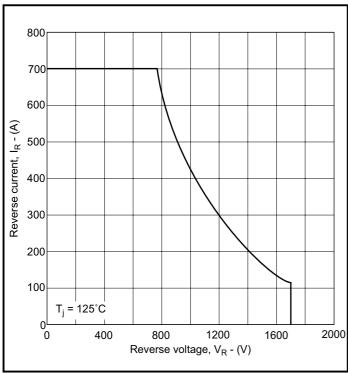


Fig. 7 Diode typical forward characteristics

Fig. 8 Reverse bias safe operating area





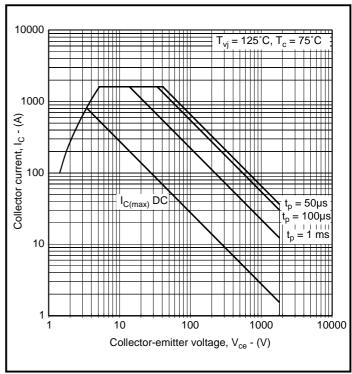
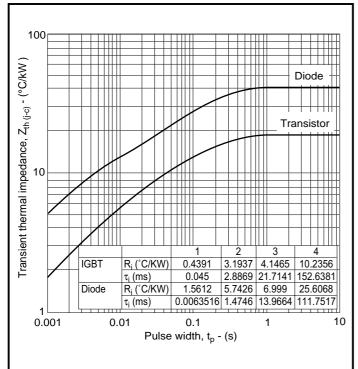


Fig. 10 Forward bias safe operating area





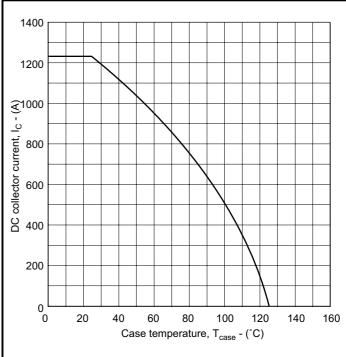


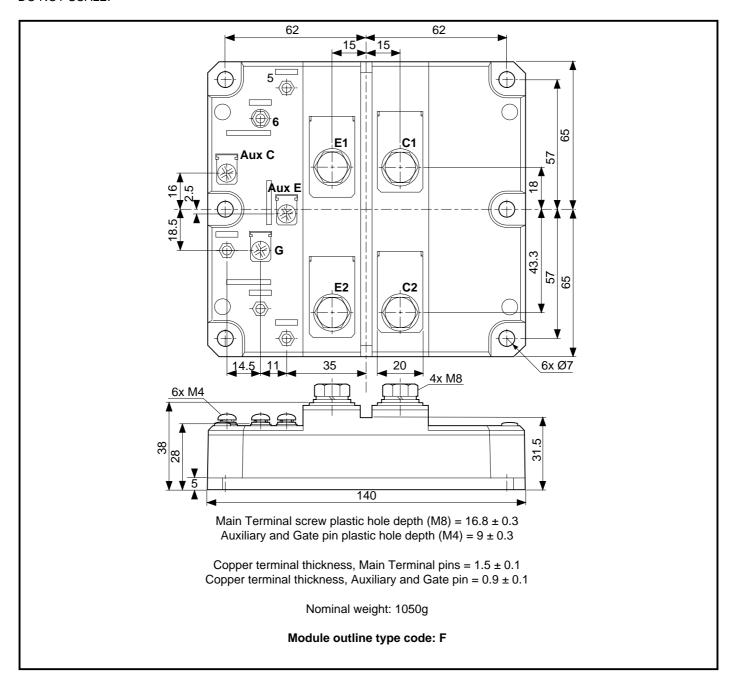
Fig. 11 Transient thermal impedance

Fig. 12 DC current rating vs case temperature



PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.





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We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group continues to offer high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

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For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or customer service office.



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